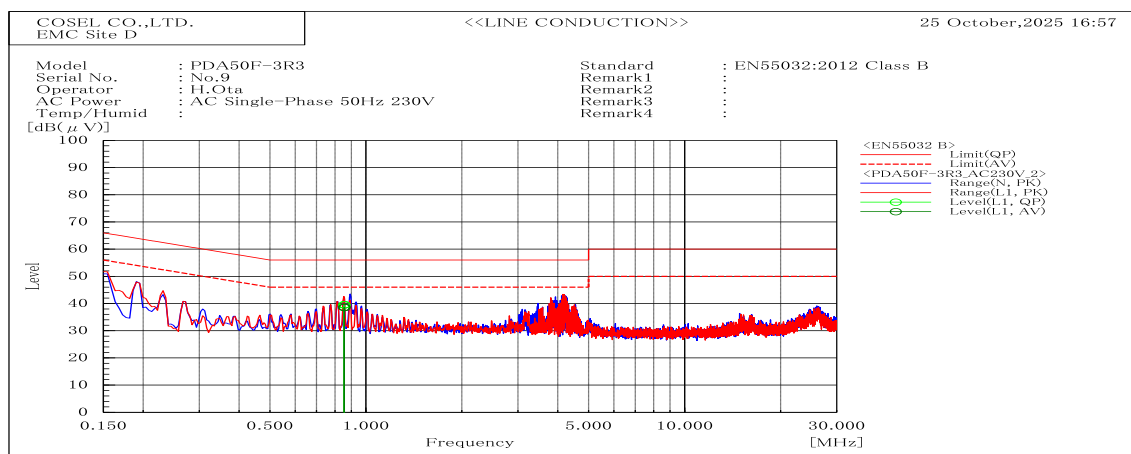
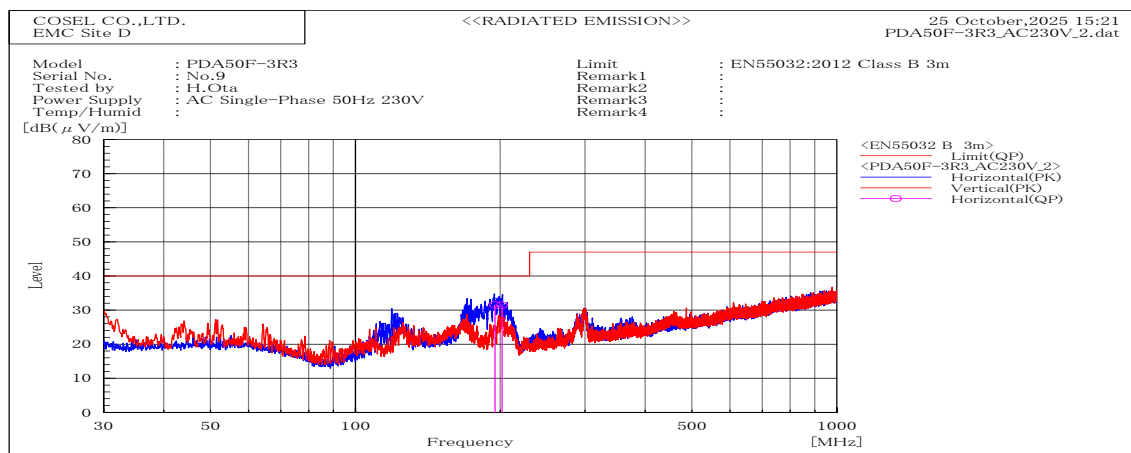


DATA SHEET		Date	08-Oct-25
Model	PDA50F-3R3	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	H.Ota



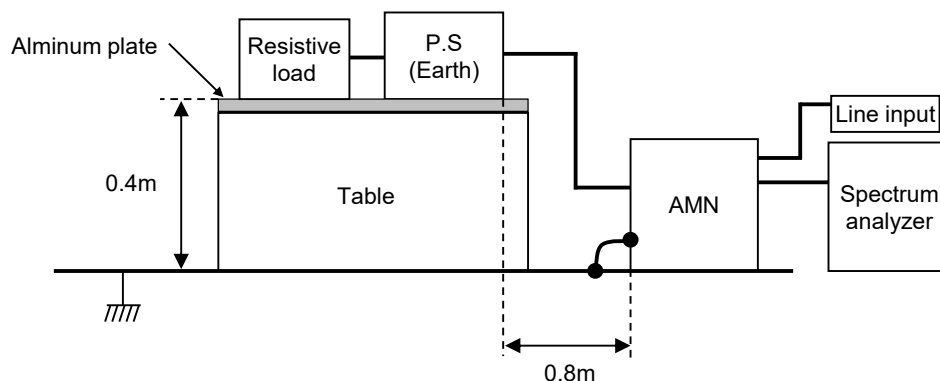
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.856	L1	39.5	38.6	56	46	16.5	7.4	Pass	
0.856	L1	39.5	38.6	56	46	16.5	7.4	Pass	
0.855	L1	39.5	38.6	56	46	16.5	7.4	Pass	



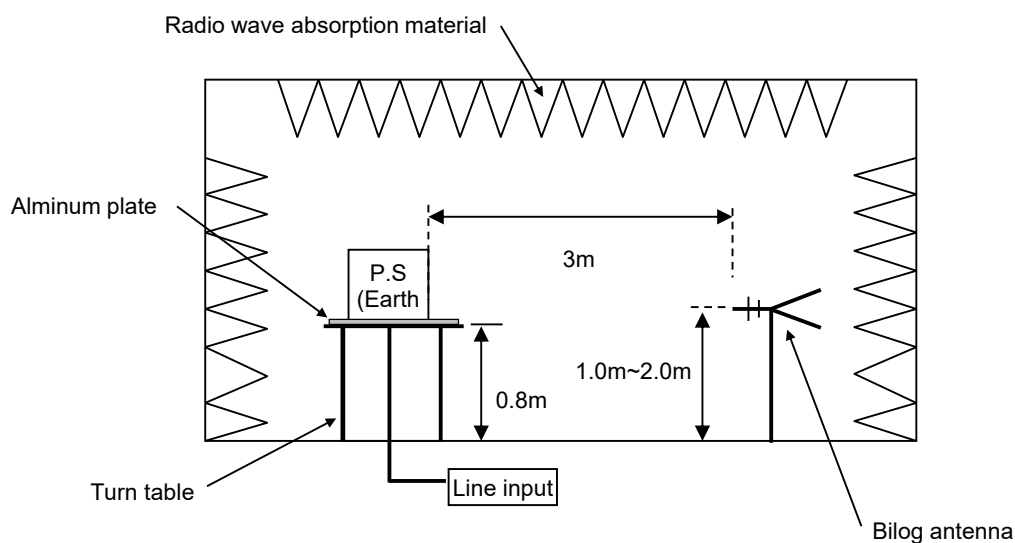
Frequency MHz	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height cm	Angle deg	Remark
			dB(μV/m) QP	dB(μV/m) QP	dB QP				
194.975	H	Stable	31.5	40	8.5	Pass	196.8	16.1	
201.694	H	Stable	31.4	40	8.6	Pass	198.3	358.7	

DATA SHEET		Date	08-Oct-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	H.Ota

### 1. Line conduction



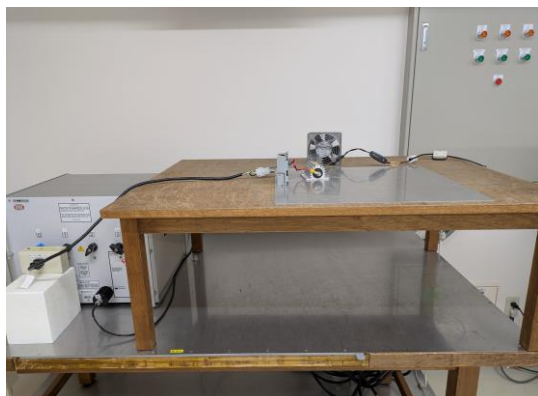
### 2. Radiated emission



## Conditions

Test : EMI  
Model Name : PDA50F-3R3

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

